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QUERY CONTROL FORM		RTIS USE ONLY	
Application No. <u>09914482</u>	Prepared by <u>L. McKee</u>	Tracking Number <u>06001653</u>	
Examiner-GAU <u>Bell 1755</u>	Date <u>9/23/04</u>	Week Date <u>8/23/04</u>	
	No. of queries <u>(1)</u>	<u>By-Us IFW</u>	

JACKET			
a. Serial No.	f. Foreign Priority	k. Print Claim(s)	<u>p. PTO-1449</u>
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

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FORM PTO-1449 U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. U 013615-2		SERIAL NO. 09/914,482	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		APPLICANT Masahiro YATAKE			
		FILING DATE August 28, 2001		GROUP 1755	
U. S. PATENT DOCUMENTS					
EXAMINER INITIALS	REFERENCE DESIGNATION	DOCUMENT NUMBER	DATE	NAME	FILING DATE IF APPROPRIATE
	AA				
FOREIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
	AB	56-163168	12/1981	JP	
	AC	11-349871	12/1999	JP	
	AD	6-504576	5/1994	JP	
	AE	93-09194	5/1993	WO	X
	AF	05-214282	8/1993	JP	
	AG	04-018465	1/1992	JP	
	AH	07-157698	6/1995	JP	
	AI	10-211693	8/1998	JP	
	AJ	02-127482	5/1990	JP	
OTHER ART (Including Author, Title, Date, Pertinent Dates, Etc.)					
	AK	Patent Abstracts of Japan of JP 56-163168 dated December 15, 1981			
	AL	Patent Abstracts of Japan of JP 11-349871 dated December 21, 1999			
	AM	Patent Abstracts of Japan of JP 05-214282 dated August 24, 1993			
	AN	Patent Abstracts of Japan of JP 04-018465 dated January 22, 1992			
	AO	Patent Abstracts of Japan of JP 07-157698 dated June 20, 1995			
	AP	Patent Abstracts of Japan of JP 10-211693 dated August 11, 1998			
	AQ	Patent Abstracts of Japan of JP 02-127482 dated May 16, 1990			
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